Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/656,576	KIM ET AL.	
Examiner	Art Unit	_
XIAO M. WU	2674	

	SEAR	CHED	
Class	Subclass	Date	Examiner
345	90-93 96, 87-89	3/18/2006	X.W.
349	46,47	3/18/2006	X.W.
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST AND INVENTOR SEARCH	3/18/2006	x.w		